GENERAL DESCRIPTION

Passivated, sensitive gate triacs in a plastic envelope, intended for use in general purpose bidirectional switching and phase control applications, where high sensitivity is required in all four quadrants.

QUICK REFERENCE DATA

SYMBOL	PARAMETER		MAX.	MAX.	UNIT
		BT136-	600E	800E	
V_{DRM}	Repetitive peak off-state voltages		600	800	V
$I_{T(RMS)}$	RMS on-state current		4	4	A
I_{TSM}	Non-repetitive peak on-state current		25	25	A

PINNING - TO220AB

PIN	DESCRIPTION
1	main terminal 1
2	main terminal 2
3	gate
tab	main terminal 2

PIN CONFIGURATION

tab

1 2 3

SYMBOL

T2   T1

G
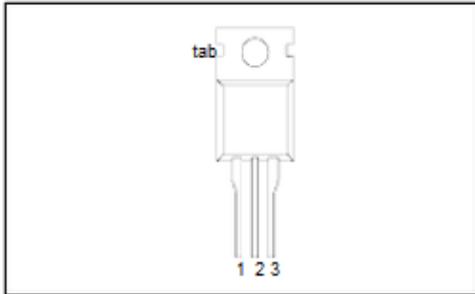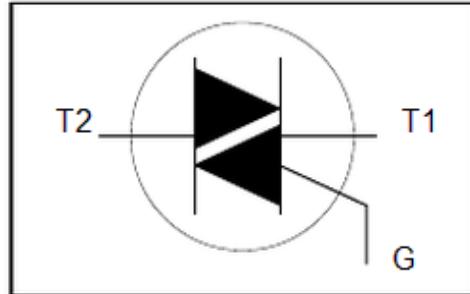
LIMITING VALUES

Limiting values in accordance with the Absolute Maximum System (IEC 134).

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.		UNIT
				-600	-800	
V_{DRM}	Repetitive peak off-state voltages		-	600[1]	800	V
$I_{T(RMS)}$	RMS on-state current	full sine wave; $T_{mb} \leq 107\ °C$	-	4		A
I_{TSM}	Non-repetitive peak on-state current	full sine wave; $T_j = 25\ °C$ prior to surge				
		t = 20 ms	-	25		A
		t = 16.7 ms	-	27		A
I^2t	I^2t for fusing	t = 10 ms	-	3.1		A^2s
dI_T/dt	Repetitive rate of rise of on-state current after triggering	$I_{TM} = 6\ A$; $I_G = 0.2\ A$; $dI_G/dt = 0.2\ A/\propto s$				
		T2+ G+	-	50		$A/\propto s$
		T2+ G-	-	50		$A/\propto s$
		T2- G-	-	50		$A/\propto s$
		T2- G+	-	10		$A/\propto s$
I_{GM}	Peak gate current		-	2		A
V_{GM}	Peak gate voltage		-	5		V
P_{GM}	Peak gate power		-	5		W
$P_{G(AV)}$	Average gate power	over any 20 ms period	-	0.5		W
T_{stg}	Storage temperature		-40	150		°C
T_j	Operating junction temperature		-	125		°C

1 Although not recommended, off-state voltages up to 800V may be applied without damage, but the triac may switch to the on-state. The rate of rise of current should not exceed 3 A/ ∝s.

THERMAL RESISTANCES

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
$R_{th\,j-mb}$	Thermal resistance junction to mounting base	full cycle	-	-	3.0	K/W
		half cycle	-	-	3.7	K/W
$R_{th\,j-a}$	Thermal resistance junction to ambient	in free air	-	60	-	K/W

STATIC CHARACTERISTICS

T_j = 25 °C unless otherwise stated

SYMBOL	PARAMETER	CONDITIONS		MIN.	TYP.	MAX.	UNIT
I_{GT}	Gate trigger current	V_D = 12 V; I_T = 0.1 A					
			T2+ G+	-	2.5	10	mA
			T2+ G-	-	4.0	10	mA
			T2- G-	-	5.0	10	mA
			T2- G+	-	11	25	mA
I_L	Latching current	V_D = 12 V; I_{GT} = 0.1 A					
			T2+ G+	-	3.0	15	mA
			T2+ G-	-	10	20	mA
			T2- G-	-	2.5	15	mA
			T2- G+	-	4.0	20	mA
I_H	Holding current	V_D = 12 V; I_{GT} = 0.1 A		-	2.2	15	mA
V_T	On-state voltage	I_T = 5 A		-	1.4	1.70	V
V_{GT}	Gate trigger voltage	V_D = 12 V; I_T = 0.1 A		-	0.7	1.5	V
		V_D = 400 V; I_T = 0.1 A; T_j = 125 °C		0.25	0.4	-	V
I_D	Off-state leakage current	V_D = $V_{DRM(max)}$; T_j = 125 °C		-	0.1	0.5	mA

DYNAMIC CHARACTERISTICS

T_j = 25 °C unless otherwise stated

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
dV_D/dt	Critical rate of rise of off-state voltage	V_{DM} = 67% $V_{DRM(max)}$; T_j = 125 °C; exponential waveform; gate open circuit	-	50	-	V/∝s
t_{gt}	Gate controlled turn-on time	I_{TM} = 6 A; V_D = $V_{DRM(max)}$; I_G = 0.1 A; dI_G/dt = 5 A/∝s	-	2	-	∝s
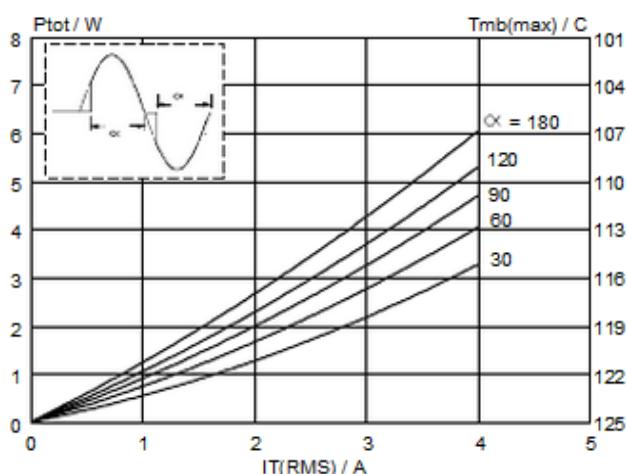
Fig.1. Maximum on-state dissipation, P_{tot}, versus rms on-state current, $I_{T(RMS)}$, where α = conduction angle.
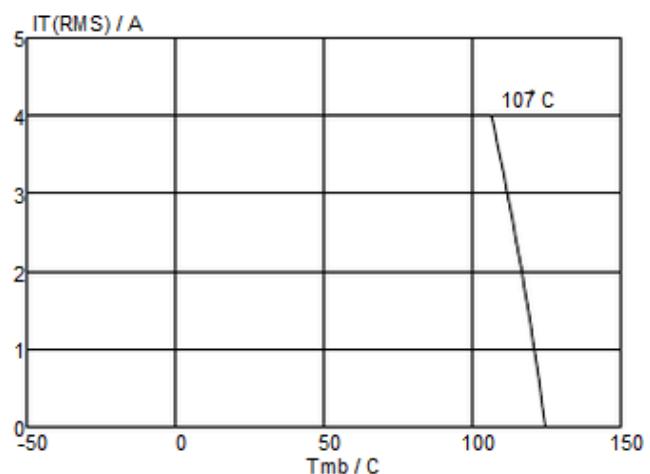
Fig.4. Maximum permissible rms current $I_{T(RMS)}$, versus mounting base temperature T_{mb}.
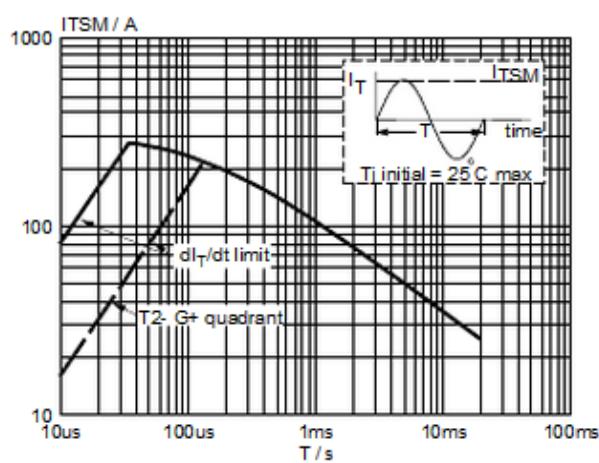
Fig.2. Maximum permissible non-repetitive peak on-state current I_{TSM}, versus pulse width t_p, for sinusoidal currents, $t_p \leq 20ms$.
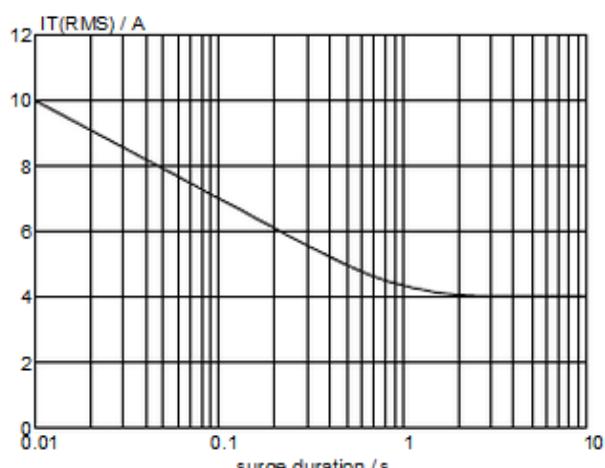
Fig.5. Maximum permissible repetitive rms on-state current $I_{T(RMS)}$, versus surge duration, for sinusoidal currents, $f = 50\ Hz$; $T_{mb} \leq 107°C$.
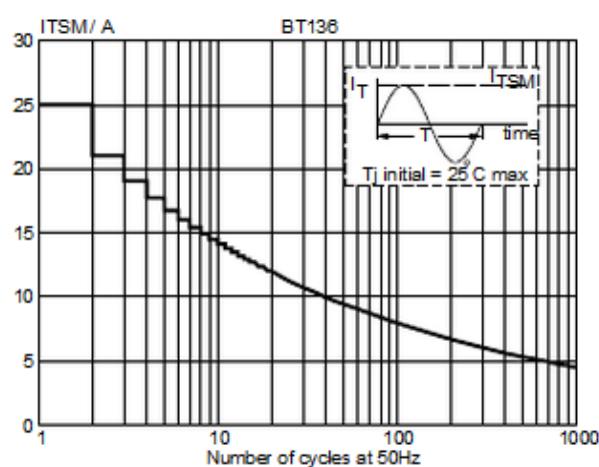
Fig.3. Maximum permissible non-repetitive peak on-state current I_{TSM}, versus number of cycles, for sinusoidal currents, $f = 50\ Hz$.
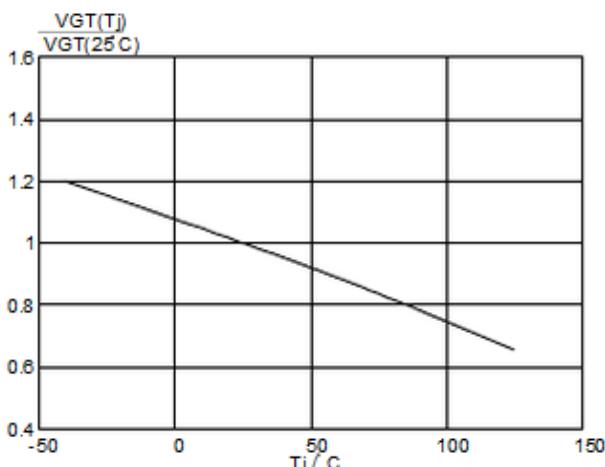
Fig.6. Normalised gate trigger voltage $V_{GT}(T_j)/V_{GT}(25°C)$, versus junction temperature T_j.